

# Poster Presentations

## [MS28-P09] Structural Investigation of the Lead-Free Ferroelectric Solid-Solution (1-x) Na<sub>0.5</sub>Bi<sub>0.5</sub>TiO<sub>3</sub>xBaTiO<sub>3</sub>

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In recent years, Na<sub>0.5</sub>Bi<sub>0.5</sub>TiO<sub>3</sub> (NBT) based solid solutions have emerged as a potential replacement for conventional lead-based piezoelectric materials. However, their application as a piezoceramic are limited by a high coercive field of 5.0-7.3 kVmm<sup>-1</sup>, low depolarization temperature (160–190°C) and low piezoelectric coefficient (75 pCm<sup>-1</sup>) [1, 2]. As a result, the binary system of (1-x)NBT-xBT (BaTiO<sub>3</sub>) has attracted significant research focus because of their superior piezoelectric properties. (1-x)NBT-xBT exhibits a morphotropic phase boundary near  $x = 6\%$  where the piezoelectric properties are enhanced [3].

However, the phase diagram is the subject of much debate, with more than 5 having been proposed to date. This controversy is unsurprising given the current uncertainty in the structure of NBT itself. A recent study based on refinements against combined X-ray and neutron diffraction of 0.96NBT-0.04BT attributed a mixture of a monoclinic Cc phase with a minor fraction of a cubic Pm-3m phase to this region [4]. In addition, under ferroelectric poling it exhibits an irreversible electric field induced phase-transition [5].

Rietveld refinements against laboratory-based high-resolution X-ray powder diffraction measurements of unpoled and poled ceramic solid-solution (1x)NBT-xBT are presented for the region  $0.02 \leq x \leq 0.1$ . A new phase diagram, as a function of composition, temperature and electric field, is shown using the refinements along with data from complementary techniques such as second harmonic generation.

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